

INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)		Docket Number (Optional) TWI-5440		Application Number NEW	
		Applicant(s) David E. Aspnes et al.			
		Filing Date HEREWITH		Group Art Unit Unknown	

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*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
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Examiner <i>David S. Aspnes</i>	Date Considered <i>1/8/04</i>
Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	